

<b>Notice of References Cited</b>	Application/Control No. 10/662,508	Applicant(s)/Patent Under Reexamination TAKAYAMA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0001992	01-2003	Kawase et al.	349/106
*	B	US-2004/0187917	09-2004	Pichler, Karl	136/263
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 03153859 A	07-1991	Japan	FUKUMOTO et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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